



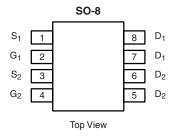
# **Dual N-Channel 2.5-V (G-S) MOSFET**

PRODUCT SUMMARY			
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A)	
20	0.025 at V <sub>GS</sub> = 4.5 V	± 7.1	
	0.035 at V <sub>GS</sub> = 2.5 V	± 6.0	

#### **FEATURES**

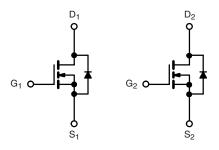
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC





Ordering Information: Si4966DY-T1-E3 (Lead (Pb)-free)

Si4966DY-T1-GE3 (Lead (Pb)-free and Halogen-free)



N-Channel MOSFET

N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	<b>S</b> T <sub>A</sub> = 25 °C, unles	ss otherwise not	ed	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	20	.,
Gate-Source Voltage		V <sub>GS</sub>	± 12	
Ocaliana Daria Ocana I/T 450 00\8	T <sub>A</sub> = 25 °C		± 7.1	
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 70 °C	l D	± 5.7	
Pulsed Drain Current (10 μs Pulse Width)		I <sub>DM</sub>	± 40	— A
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	1.7	
	T <sub>A</sub> = 25 °C	D	2	107
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 70 °C	P <sub>D</sub>	1.3	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Limit	Unit	
Maximum Junction-to-Ambient <sup>a</sup>	R <sub>thJA</sub>	62.5	°C/W	

Notes:

a. Surface Mounted on FR4 board,  $t \le 10$  s.

For SPICE model information via the Worldwide Web: www.vishav.com/www/product/spice.htm.

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<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, unless otherwise noted									
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit			
Static									
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}$ , $I_D = 250 \mu A$	0.6		1.5	V			
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA			
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V			1	μΑ			
	I <sub>DSS</sub>	V <sub>DS</sub> = 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			5				
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	20			Α			
	D	$V_{GS} = 4.5 \text{ V}, I_D = 7.1 \text{ A}$		0.019	0.025	Ω			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 2.5 \text{ V}, I_D = 6.0 \text{ A}$		0.025	0.035				
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 7.1 A		27		S			
Diode Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>S</sub> = 1.7 A, V <sub>GS</sub> = 0 V			1.2	V			
Dynamic <sup>b</sup>									
Total Gate Charge	$Q_g$			25	50				
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 7.1 \text{ A}$		6.5		nC			
Gate-Drain Charge	$Q_{gd}$			4					
Gate Resistance	$R_{g}$	f = 1 MHz		1.6	2.7	Ω			
Turn-On Delay Time	t <sub>d(on)</sub>			40	60				
Rise Time	t <sub>r</sub>	$V_{DD}$ = 10 V, $R_L$ = 10 $\Omega$ $I_D \cong$ 1 A, $V_{GEN}$ = 4.5 V, $R_g$ = 6 $\Omega$		40	60	ns			
Turn-Off Delay Time	t <sub>d(off)</sub>			90	150				
Fall Time	t <sub>f</sub>			40	60				
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 1.7 A, dI/dt = 100 A/μs		40	80				

#### Notes:

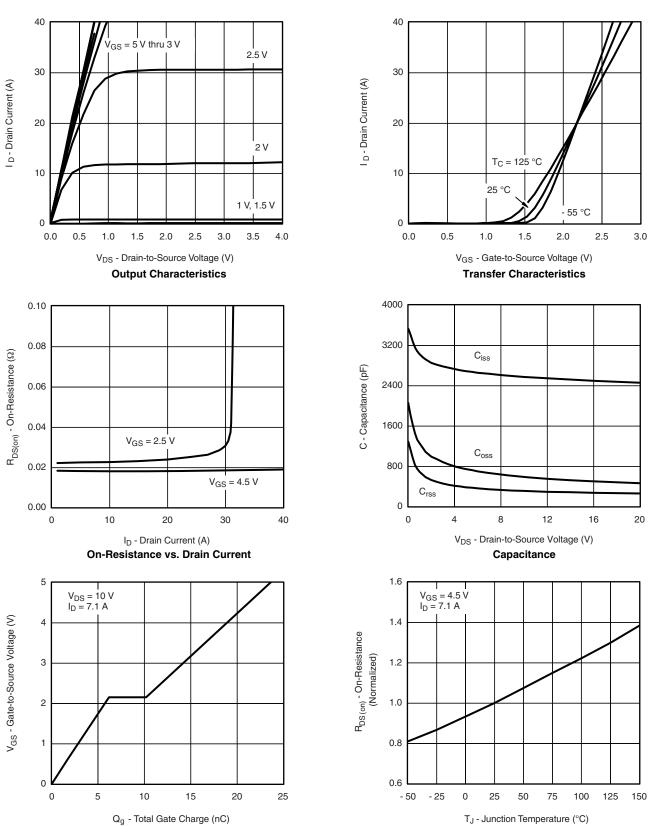
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



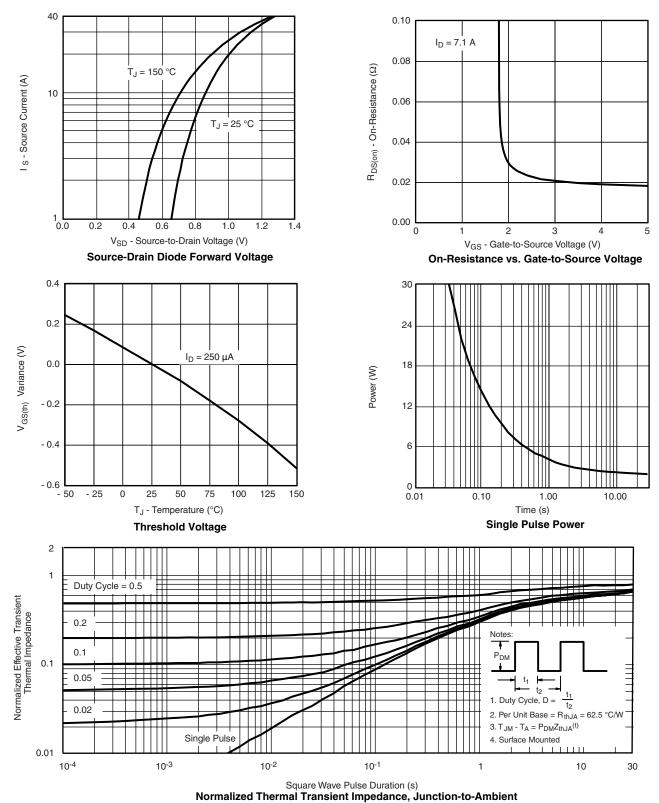
Document Number: 70718 S09-0869-Rev. D, 18-May-09 **Gate Charge** 

On-Resistance vs. Junction Temperature

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Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="https://www.vishay.com/ppg270718">www.vishay.com/ppg270718</a>.





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